TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (L^2 - π -MOSV)

2SJ378

Relay Drive, DC-DC Converter and Motor Drive Applications

• 4-V gate drive

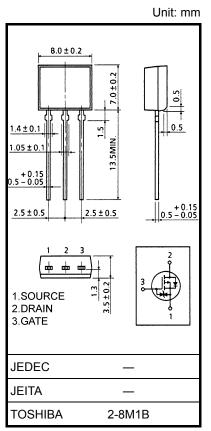
• Low drain-source ON resistance : R_{DS} (ON) = 0.16 Ω (typ.) • High forward transfer admittance : $|Y_{fs}| = 4.0 \text{ S}$ (typ.)

• Low leakage current $: I_{DSS} = -100 \,\mu\text{A} \,(\text{max}) \,(V_{DS} = -60 \,\text{V})$

• Enhancement mode : $V_{th} = -0.8 \sim -2.0 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit
Drain-source voltage		V_{DSS}	-60	V
Drain-gate voltage (R	_{GS} = 20 kΩ)	V_{DGR}	-60	V
Gate-source voltage		V_{GSS}	±20	V
Drain current	DC (Note 1)	I _D	-5	Α
	Pulse(Note 1)	I _{DP}	-20	Α
Drain power dissipation	n	P_{D}	1.3	W
Single pulse avalanch	e energy (Note 2)	E _{AS}	273	mJ
Avalanche current		I _{AR}	-5	Α
Repetitive avalenche	energy (Note 3)	E _{AR}	0.13	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature r	ange	T _{stg}	-55~150	°C



Weight: 0.54 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient	R _{th (ch-a)}	96.1	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = -25 V, T_{ch} = 25°C (initial), L = 14.84 mH, R_G = 25 Ω , I_{AR} = -5 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.

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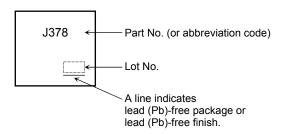
Electrical Characteristics (Ta = 25°C)

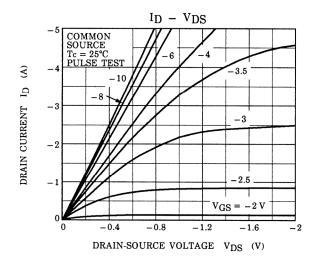
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	irrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = -60 V, V _{GS} = 0 V	_	_	-100	μA
Drain-source br	eakdown voltage	V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-60	_	_	V
Gate threshold v	voltage	V _{th}	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$	-0.8	_	-2.0	V
Drain-source ON resistance		R _{DS (ON)}	$V_{GS} = -4 \text{ V}, I_D = -2.5 \text{ A}$	_	0.24	0.28	- Ω
			V _{GS} = -10 V, I _D = -2.5 A	_	0.16	0.19	
Forward transfe	r admittance	Y _{fs}	V _{DS} = -10 V, I _D = -2.5 A	2.0	4.0	_	S
Input capacitano	e	C _{iss}			630	_	
Reverse transfe	r capacitance	C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	95	_	pF
Output capacitance		Coss		_	290	_	
Switching time	Rise time	t _r	$V_{\text{GS}} \stackrel{\text{OV}}{\longrightarrow} I_{\text{D}} = -2.5 \text{A}$ $V_{\text{CS}} \stackrel{\text{OV}}{\longrightarrow} V_{\text{OUT}}$ $R_{\text{L}} = 12 \Omega$ $V_{\text{DD}} = -30 \text{V}$	_	25	_	
	Turn-on time	ton		_	45	_	no
	Fall time	t _f		_	55	_	ns
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_W = 10 \mu s$	_	200	_	
Total gate charge (Gate-source plus gate-drain)		Qg	$V_{DD} \approx -48 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -5 \text{ A}$		22	_	nC
Gate-source charge		Qgs		_	16	_	
Gate-drain ("miller") charge		Q _{gd}			6	_	

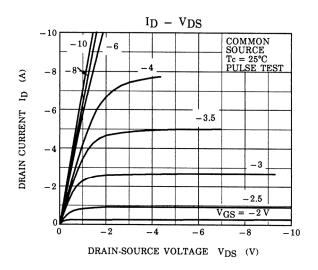
Source-Drain Ratings and Characteristics (Ta = 25°C)

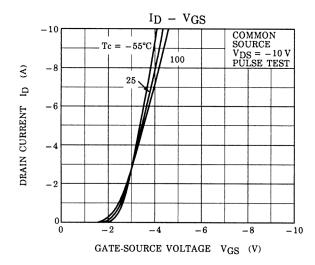
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	-5	Α
Pulse drain reverse current (Note 1)	I _{DRP}	-	_	_	-20	А
Forward voltage (diode)	V _{DSF}	I _{DR} = -5 A, V _{GS} = 0 V	_	_	1.7	V
Reverse recovery time	t _{rr}	I _{DR} = -5 A, V _{GS} = 0 V	1	80	_	ns
Reverse recovery charge	Qrr	dI_{DR} / $dt = 50 \text{ A}$ / μ S	_	0.1	_	μC

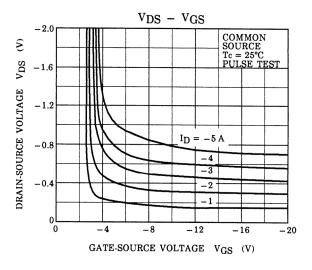
Marking

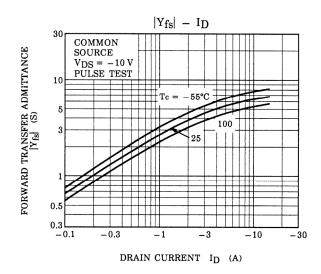


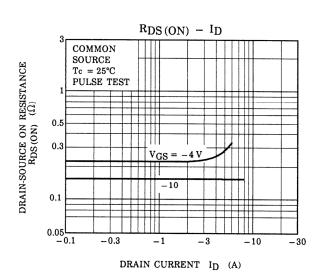




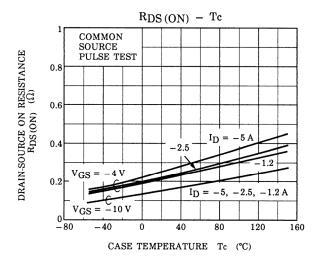


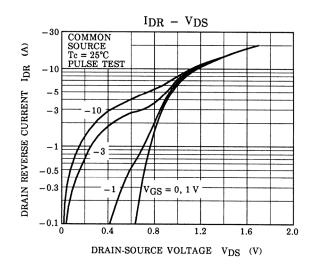


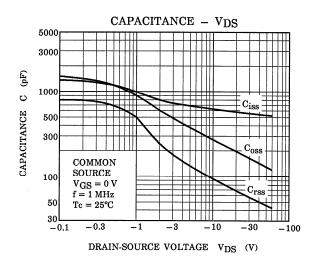


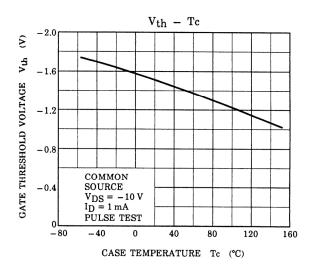


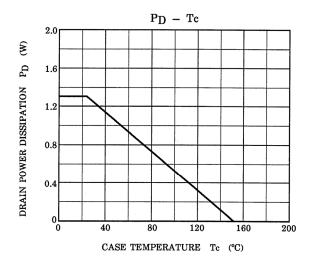
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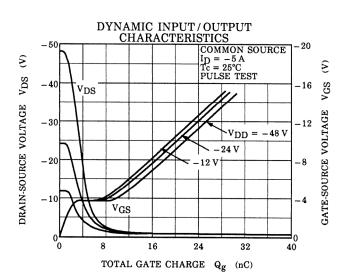


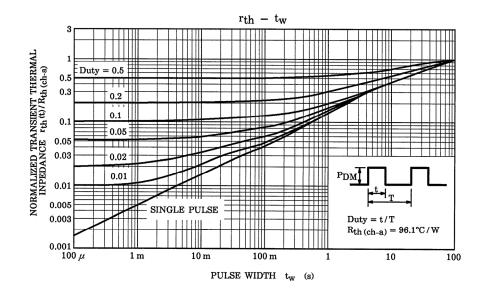


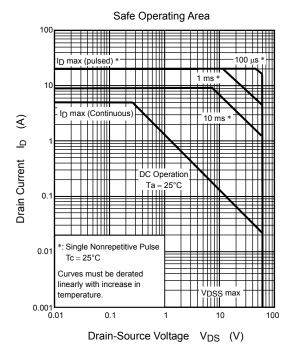


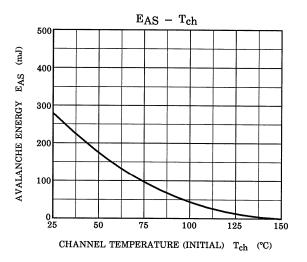


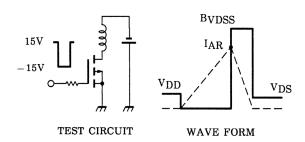












$$\begin{array}{ll} R_{\mbox{\scriptsize G}}\!=\!25\Omega \\ V_{\mbox{\scriptsize DD}}\!=\!-25\mbox{\scriptsize V}, \; L\!=\!14.84\mbox{\scriptsize mH} \end{array} \quad E_{\mbox{\scriptsize AS}}\!=\!\frac{1}{2}\cdot L \cdot I^2\cdot (\frac{B\mbox{\scriptsize VDSS}}{B\mbox{\scriptsize VDSS}\!-\!\mbox{\scriptsize VDD}}) \end{array}$$

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